

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10633884	KRAISS ET AL.
	Examiner Nguyen, Phillip H	Art Unit 2191

Notes	Date	Examiner
EAST: TEXT SEARCH, CLASS SEARCH (717 AND 707), INVENTOR SEARCH FOR DOUBLE PATENTING. SEARCH HISTORY IS ENCLOSED. CONSULTED WITH WEI ZHEN ABOUT 101 PROBLEM.	11/6/2006	PHILLIP NGUYEN H.
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717, 707	ALL	11/6/2006	PHILLIP NGUYEN H.

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